Organic light emitting diode (OLED) displays —

Part 1-1: Generic specifications
National foreword

This British Standard is the UK implementation of EN 62341-1-1:2009. It is identical to IEC 62341-1-1:2009. It supersedes BS IEC 62341-1-1:2009 which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on this committee can be obtained on request to its secretary.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

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Compliance with a British Standard cannot confer immunity from legal obligations.

This British Standard was published under the authority of the Standards Policy and Strategy Committee on 31 July 2009

Amendments/corrigenda issued since publication

<table>
<thead>
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<th>Date</th>
<th>Text affected</th>
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<tr>
<td>30 June 2010</td>
<td>This corrigendum renumbers BS IEC 62341-1-1:2009 as BS EN 62341-1-1:2009</td>
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Organic light emitting diode (OLED) displays -
Part 1-1: Generic specifications
(IEC 62341-1-1:2009)
Foreword

The text of document 110/168/FDIS, future edition 1 of IEC 62341-1-1, prepared by IEC TC 110, Flat panel display devices, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 62341-1-1 on 2009-12-01.

The following dates were fixed:

- latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2010-09-01
- latest date by which the national standards conflicting with the EN have to be withdrawn (dow) 2012-12-01

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 62341-1-1:2009 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

<table>
<thead>
<tr>
<th>Standard</th>
<th>Note</th>
<th>Harmonized as EN 60027-1:2006 (not modified).</th>
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<tr>
<td>IEC 60027-1</td>
<td>NOTE</td>
<td>Harmonized as EN 60027-1:2006 (not modified).</td>
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<td>IEC 60027-4</td>
<td>NOTE</td>
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<tr>
<td>ISO 1101</td>
<td>NOTE</td>
<td>Harmonized as EN ISO 1101:2005 (not modified).</td>
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## Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

**NOTE** When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<table>
<thead>
<tr>
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<tr>
<td>IEC 60410</td>
<td>1973</td>
<td>Sampling plans and procedures for inspection by attributes</td>
<td>-</td>
<td>-</td>
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<tr>
<td>IEC 60747-1</td>
<td>2006</td>
<td>Semiconductor devices - Part 1: General</td>
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<td>IEC 62341-1-2</td>
<td>2009&lt;sup&gt;1)&lt;/sup&gt;</td>
<td>Organic light emitting diode displays - Part 1-2: Terminology and letter symbols</td>
<td>EN 62341-1-2</td>
<td>2009&lt;sup&gt;2)&lt;/sup&gt;</td>
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<td>IEC 62341-5</td>
<td>2009</td>
<td>Organic Light Emitting Diode (OLED) displays - Part 5: Environmental testing methods</td>
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<td>IEC QC 001002 Series</td>
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<td>IEC quality assessment system for electronic components (IECQ) - Rules of procedure</td>
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<td>Sampling procedures for inspection by attributes</td>
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<sup>1</sup> Undated reference.  
<sup>2</sup> Valid edition at date of issue.
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